

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : TBD  
Applicant : Kazumasa Yoshima  
Filed : Herewith  
Title : "CONSUMABLE ELECTRODE ARC WELDING METHOD"  
  
Confirmation No. : TBD  
TC/A.U. : TBD  
Examiner : TBD  
  
International App. No. : PCT/JP2005/007543  
International Flg. Date : April 20, 2005  
  
Customer No. : 052054  
Docket No. : 39625

INFORMATION DISCLOSURE STATEMENT

Mail Stop PCT  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, Va. 22313-1450

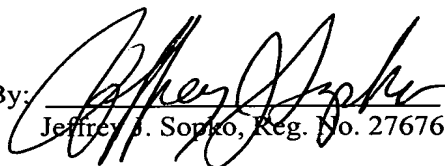
Sir/Madam:

In accordance with Rule 56, applicant is aware of the publications listed in the International Search Report (ISR, copy enclosed) and in the enclosed copy of Patent Office Form 1449. Copies of the publications cited in the International Search Report are not enclosed as they were previously forwarded by the International Bureau, however, a copy of each publication cited in the specification is enclosed.

If there are any fees required by this communication, please charge such fees to our Deposit Account No. 16-0820, Order No. 39625.

Respectfully submitted,

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<b>INFORMATION DISCLOSURE CITATION BY APPLICANT</b> <i>(USE SEVERAL SHEETS IF NECESSARY)</i>		APPLICANT: <b>Kazumasa Yoshima</b>	
		FILING DATE: <b>Herewith</b>	GROUP ART UNIT: <b>TBD</b>

## U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Name	Class	Subclass	Filing Date If Appropriate
	A						
	B						
	C						
	D						
	E						
	F						
	G						
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	I						
	J						
	K						

## FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation
	L	5-245638	09/1993	JAPAN			Cited on ISR
	M	6-54462	07/1994	JAPAN			Cited on ISR
	N	2002-361413	12/2002	JAPAN			Cited in Specification-English Abstract
	P	2002-361414	12/2002	JAPAN			Cited in Specification-English Abstract
	Q	2003-62669	03/2003	JAPAN			Cited on ISR

OTHER REFERENCES *(Including Author, Title, Date, Pertinent Pages, Etc.)*

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